



University of Michigan – Shanghai Jiao Tong University Joint Institute
Center of Optics and Optoelectronics

VE 320 – Summer 2012 Introduction to Semiconductor Device

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NANO ENERGY LAB

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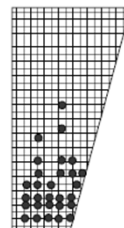
Carrier Density

Carrier number = Number of states x filling factor

Quantum
Mechanics

Statistical
Mechanics

Total number of occupants
= Number of apartments
X The fraction occupied



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Statistical Laws

Need to define laws that the particles obey

Some common distribution laws:

Maxwell Boltzmann:

particles distinguishable by number, no limit on number of particles in each energy state

Bose-Einstein:

particles are indistinguishable, no limit on number of particles in each energy state

Fermi-Dirac:

particles are indistinguishable, only one particle in each energy state

Which would you expect to apply for electrons in a semiconductor?



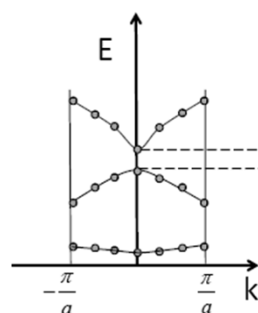
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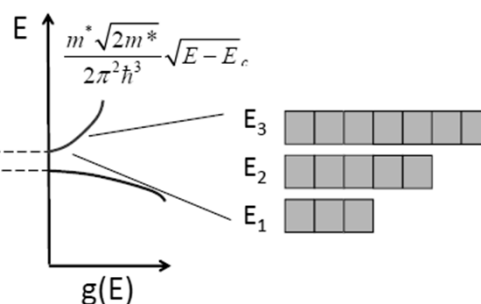
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E-k diagram and Electronic states

Energy-Band



Density of States

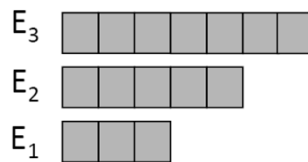


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Rules for Filling up States



- Pauli Principle: Only one electron per state
- Total number of electrons is conserved $N_T = \sum_i N_i$
- Total energy of the system is conserved $E_T = \sum_i E_i N_i$

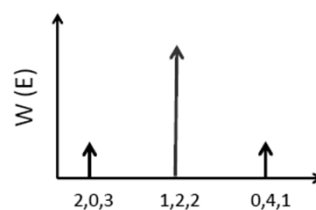
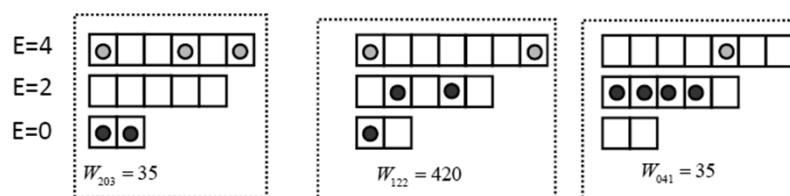


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Occupation Statistics



Choose the most probable configuration.

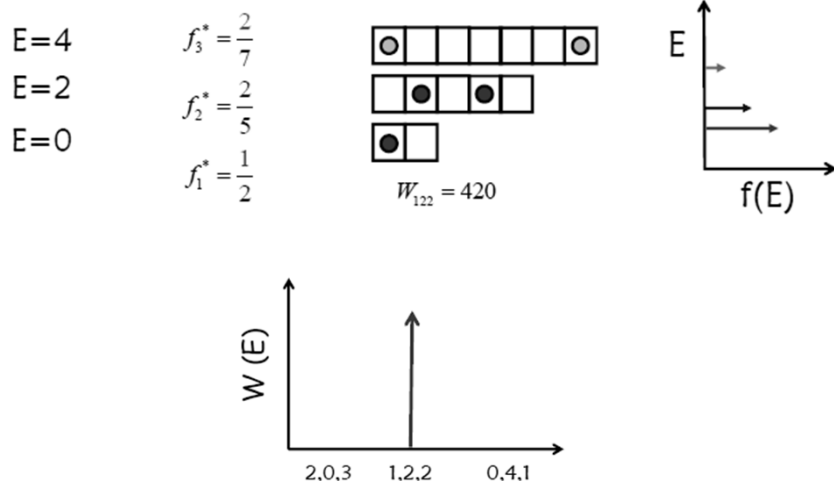


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Occupation Statistics



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For N States



$$W_c = \prod_i \frac{S_i!}{(S_i - N_i)! N_i!}$$

Recall. $W_{203} = \frac{2!}{1!2!} \cdot \frac{5!}{0!5!} \cdot \frac{7!}{3!4!}$

$$\ln(W) = \sum_i [\ln S_i! - \ln(S_i - N_i)! - \ln N_i!]$$

$$\approx \sum_i [S_i \ln S_i - S_i - (S_i - N_i) \ln(S_i - N_i) + (S_i - N_i) - N_i \ln N_i + N_i]$$

Stirling approx.

$$= \sum_i [S_i \ln S_i - (S_i - N_i) \ln(S_i - N_i) - N_i \ln N_i]$$



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Optimization with Lagrange-Multiplier

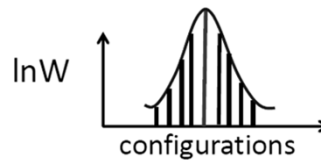
$$\delta \ln(W) = \sum_i \frac{\partial \ln W}{\partial N_i} dN_i$$

$$\delta \ln(W) = \sum_i \frac{\partial \ln W}{\partial N_i} dN_i$$

$$\approx \sum_i \left[\ln \left(\frac{S_i}{N_i} - 1 \right) dN_i \right] - \alpha \sum_i dN_i - \beta \sum_i E_i dN_i$$

$$= \sum_i \left[\ln \left(\frac{S_i}{N_i} - 1 \right) - \alpha - \beta E_i \right] dN_i$$

Choose the most probable configuration.



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Final Steps

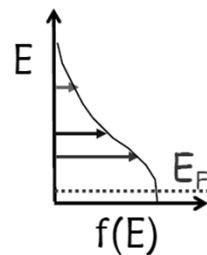
$$\left[\ln \left(\frac{S_i}{N_i} - 1 \right) - \alpha - \beta E_i \right] = 0$$

$$f(E) \equiv \frac{N_i}{S_i} = \frac{1}{1 + e^{\alpha + \beta E}} \quad f_{\max}(E) = 1$$

$$\text{At } E = E_F, f(E_F) = \frac{1}{2} \Rightarrow \alpha + \beta E_F = 0$$

$$f(E) = \frac{N_i}{S_i} = \frac{1}{1 + e^{\beta(E - E_F)}} = \frac{1}{1 + e^{(E - E_F)/k_B T}}$$

$$\text{At } E \rightarrow \infty, f_{\text{Boltzman}}(E) = A e^{-E/k_B T} \Rightarrow \beta = \frac{1}{k_B T}$$



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Fermi-Dirac Distribution Function

$$f(E) = \frac{N(E)}{g(E)} = \frac{1}{1 + \exp\left(\frac{E - E_F}{kT}\right)}$$

k = Boltzmann Constant

$$k = 8.617 \times 10^{-5} \text{ eV/K}$$

$$kT = 0.026 \text{ eV at } T = 300\text{K}$$

Can you see $f(E)$ is always smaller than one?

BTW, from now on, since we will not talk about wave number any more, we will use $k = k_B$, which is the Boltzmann constant, to be consistent with the textbook.



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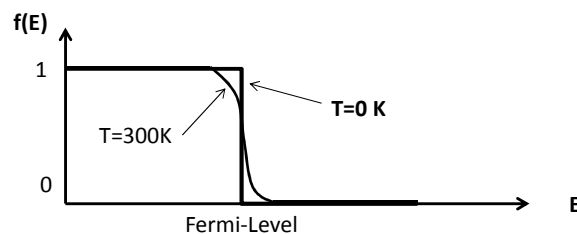
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Fermi-Dirac Distribution

$$f(E) = \frac{N(E)}{g(E)} = \frac{1}{1 + \exp\left(\frac{E - E_F}{kT}\right)}$$

Assume arbitrary Fermi-level, plot $f(E)$ at $T=0$ K and $T= 300$ K



Apply the Fermi-Dirac distribution function to electrons in a semiconductor. If $g(E)$ is the density of states, what does $f(E)$ tell us?



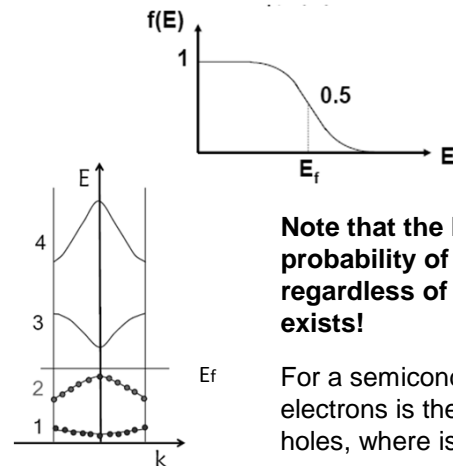
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Fermi Energy

At E_f , $f(E)=1/2$



Note that the Fermi function is the probability of occupation, regardless of whether or not a state exists!

For a semiconductor, if the number of electrons is the same as the number of holes, where is E_f located at?



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Approximation to Fermi-Dirac Statistics

For $E - E_f \gg kT$

$$f(E) \approx \frac{1}{\exp\left(\frac{E - E_f}{kT}\right)} = \exp\left(-\frac{E - E_f}{kT}\right)$$

You can assume this approximation is valid for $(E - E_f) > 3kT$



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Summary

- The distribution of electrons follows Fermi-Dirac statistics
- Fermi level is critical for determining the number of carriers in semiconductors.



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